## **Department of Engineering – Risk Assessment**

Ref No.

Title of project/experiment/activity	22	WC II	1.1
Atomic Force Microscopy			
Location of activity	Start and	end dates	
EEDB Annexe, Ground floor,	10/6/2016 – open-ended		
Atomic Force Microscopy Laboratory			

## Brief description (or attach procedure/protocol)

Atomic Force Microscopy is used for general sample surface characterization. The sample is placed on a motorized stage. The sample surface is scanned by an oscillating tip. A laser (633nm) is reflected from cantilever and the position of the reflected laser beam is monitored by a photodiode. The cantilever is deflected due to its interaction with the surface, which will in turn be reflected in a change in the reflected laser beam on the photodiode. Different sample properties such as conductivity and well as surface potential differences can be mapped with special modules and tips as well.

Hazard	Effect	Control measures	Residual risk
Pinch point	Skin damage, bruises	The motorized stage can move in x-y direction. The movements of all axes are slow, but are capable of exerting high forces. Users should wait for the stage movement to finish before loading and unloading samples to avoid their hand being caught.  Users should be careful when closing and opening hood of the AFM to not hit their head.	Low risk
Low power laser, Class 2M, 1mW max. power, 650-695 nm	eye damage	Low power laser is pointing downwards without any diffuse reflections. Users should not try to stare directly into the laser for long time or view laser through optics. Position where laser light is emitted is indicated on the scanner head by safety signs.	Low risk
Electrical shock	Shock to user	The internal electronics of the microscope, controllers, and peripheral equipment feature high-voltage components. All are no user-serviceable parts and can only be serviced by Bruker. Users should not attempt any system repairs.	Low risk

**Personal Protective Equipment required** [eye/face protection, respiratory protection, gloves, lab coat etc] No general personal protective equipment is required. Some samples might require wearing gloves.

## **Emergency Instructions & First Aid**

Fire: In case of fire, the fire alarm should be activated and fire service called. Evacuate the building.

Any special monitoring required [e.g. hearing test, vibration monitoring, health surveillance]

N/A

Further control measures required? If yes, list with actions.

N/A

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iological/Laser/Radiation Approval [req	quires relevant Specialist Safety Officer sign	lature ana aatej
gnature of Departmental Laser Officer:		
	Date:	
ut of hours/Lone working		
ut of hours working must be authorize	ed according to Engineering Department	regulation.
	e and sufficient assessment of risk and that be reviewed if additional risks not covered	
lentified or if there is any reason to indi	cate that the control measures are insuffici	ient.
Name of Assessor	Signature	Date
Anna Ott	Luna Off	9.6. 2016
Email: ako24@cam.ac.uk		J.6. 7076
Name of Supervisor Prof. A.C. Ferrari	Signature	Date
Email: acf26@cam.ac.uk		
Local Safety Coordinator	Signature	Date
	Dand Handa	1/11/16
Departmental Safety Office	Signature	Date
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Title of project/experiment/activity		
Atomic Force Microscopy		

approval by For Mar. Avail (Dryling Alaverdgen)